

<b>Notice of References Cited</b>	Application/Control No. 09/885,315	Applicant(s)/Patent Under Reexamination HAYASHI ET AL.	
	Examiner Kristie Shingles	Art Unit 2141	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,738,352	05-2004	Yamada et al.	370/238
*	B US-6,424,992	07-2002	Devarakonda et al.	709/203
*	C US-5,812,549	09-1998	Sethu, Harish	370/389
*	D US-2006/0112176	05-2006	Liu et al.	709/223
*	E US-2006/0109853	05-2006	Matsuzawa et al.	370/400
*	F US-6,272,548	08-2001	Cotter et al.	709/239
*	G US-6,754,843	06-2004	Lu et al.	714/4
	H US-			
	I US-			
	J US-			
	K US-			
	L US-			
	M US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				
	O				
	P				
	Q				
	R				
	S				
	T				

**NON-PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.